

Precise Bunch charge measurement using BPM pickup

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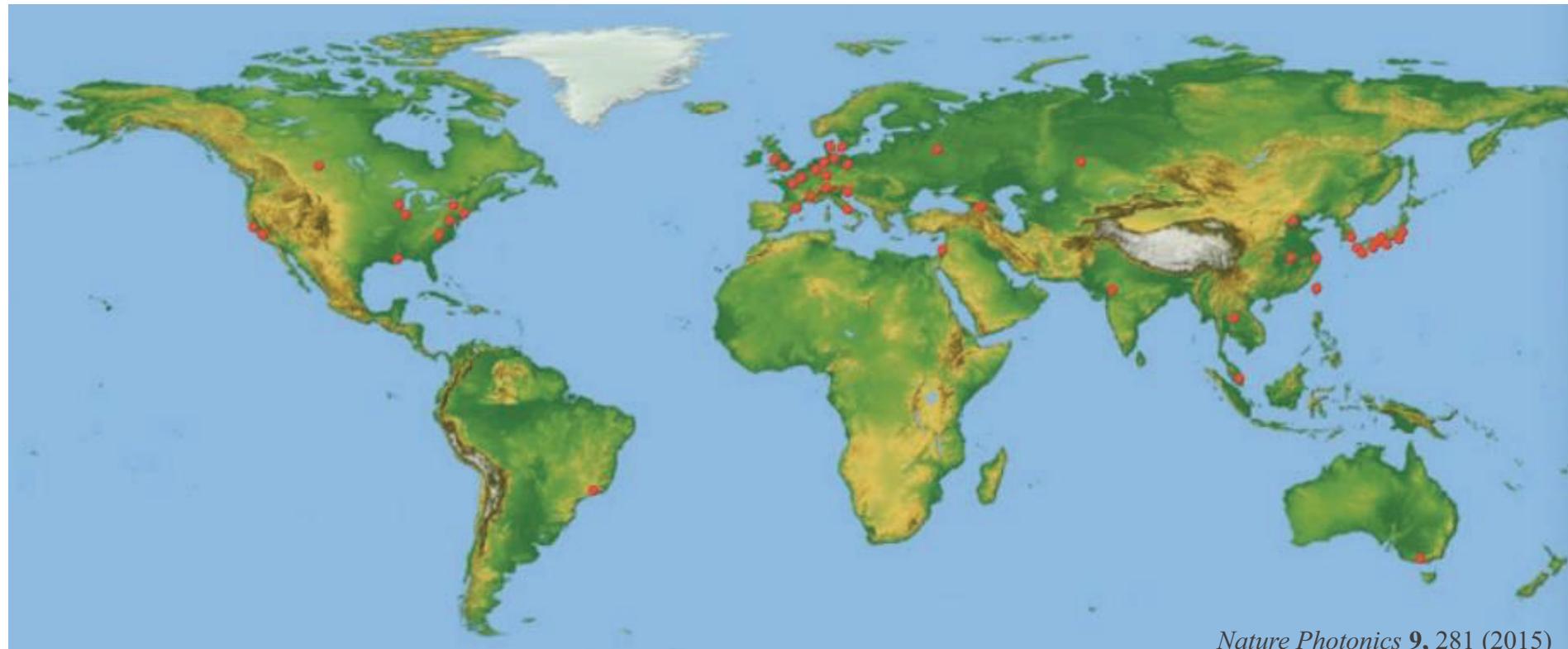




Outline

- Introduction & Background
- Theory & Simulation
- Signal conditioning & Data processing
- Beam experiment
- Discussion & Summary
- Acknowledge

Introduction



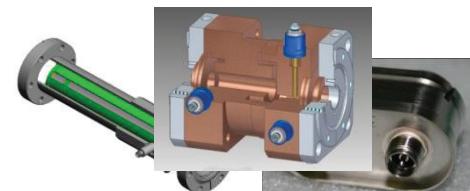
- With the development of accelerator technology, more than 60 accelerator facilities are in operation or under construction worldwide
- For accelerator facilities, especially for user facilities, precise measurement and feedback of bunch charge is very important for its stable operation

Introduction



□ Methods of measuring bunch charge

Methods	Faraday cup	DCCT	ICT	BPM	...
Characteristics	Intercepting low current Absolute measure	Non-intercepting DC current Absolute measure	Non-intercepting Ultrafast short pulse Absolute measure	Non-intercepting High resolution Relative measure	
Measured parameters	Pulse current Long / short pulse waveform	Beam lifetime DC current	Impulse charge	Pulse current / Bunch by bunch current / DC current	
Time response	ns ~ us	DC ~ ms	ps ~ ns		
Performance		~ μA	~ 1% (~ pC)	~ 0.1%	
Applications	LINAC / transfer line	Storage ring / Booster	LINAC / transfer line	Storage ring / LINAC/transfer line	





Typical application

Lab or Machine	method	Parameters	Application	Performance	Reference
ALS	Sum of BPM	ADC、FPGA、phase shift	Beam charge (storage ring) Beam loss	0.2 pC	[1]
BEPC-II	Sum of BPM	Board band RF front-end、peak-value sampling	Bunch-by-bunch charge (storing ring)	10 uA / bucket	[2]
Euro-XFEL	Toroid	Commercial AMC(SIS8300-L2D) MTCA.4	Machine protection Interlocks Dark current monitor (FLASH)	< 0.2pC rms	[3]、[4]
SWISS - FEL	Turbo-ICT	BCM-RF、NI-USB-9162	Low bunch charge (FEL)	55 fC @ 5pC (~1.1 %)	[5]
SWISS - FEL	Resonant SBPM	Freq.: 500 MHz / Qload: 6.2@monopole 5 GSPS direct Sampling	Low bunch charge	< 30 fC @ 2 pC (~1.5 %)	[6]
Euro-XFEL	CBPM	3.3GHz / Q = 70 16-bit、161 MSPS (IQ)	Bunch charge Machine protection	85 fC rms @ 210 pC (~ 0.04 %)	[7]、[4]
SWISS - FEL	CBPM	4.9266 GHz / Q =1000 16-bit、161 MSPS (~134M IF)	Low bunch charge (FEL)	2 fC @ 5 pC (~ 0.04 %)	[8]
		3.2844 GHz / Q =40 16-bit、161 MSPS (IQ)		5 fC @ 7 pC (~ 0.07 %)	
CLC	CBPM	15 GHz / Q = 120 10-bit、2 GSPS (~200M IF)	Bunch charge	0 .011 nC @ 3.4 nC (~ 0.32 %)	[9]
FLASH	CBPM	3.3GHz / Q = 70 MBU by PSI (IQ)	Bunch charge	< 0.2 pC @ 100 pC (~ 0.2 %)	[3]



- [1] Santis SD, Li D, Norum W, Portmann G. Proceedings of the 7th International Beam Instrumentation Conference, September 12-16, 2016[C]. Shanghai, China.
- [2] Deng Q.Y, Cao J.S, Ye Q, *et al.*, Bunch current measurement system for BEPCII storage ring[J]. *High Power Laser and Particle Beams*, 2014, 26: 075101.
- [3] N. Baboi, D. Nölle, *et al.* Commissioning of the FLASH2 Electron Beam Diagnostics in respect to its Use at the European XFEL, IBIC14
- [4] The Diagnostic System at the European XFEL; Commissioning and First User Operation, IBIC18
- [5] S.Artinian, J.Bergoz, *et al.* DEVELOPMENT AND FIRST TESTS OF A HIGH SENSITIVITY CHARGE MONITOR FOR SwissFEL , IBIC'12
- [6] Keil B, Citterio A, Dehler M, et al. Commissioning of the low-charge resonant stripline BPM system for the SwissFEL test injector[C]//Proc. FEL. 2010: 429.
- [7] M. Stadler, et al. Beam test results of undulator cavity BPM electronics for the European XFEL[C], IBIC2012, Tsukuba, Japan.
- [8] V. Schlott, V. Arsov, et al. Commissioning Results and First Operational Experience with SwissFEL Diagnostics, IBIC'17.
- [9] F. J. Cullinan, *et al.* Long bunch trains measured using a prototype cavity beam position monitor for the Compact Linear Collider[J]. Physical review special topics. 2015, 18(112802).

Research Motivation & Object



SSRF

- Precise measurement of Bunch-by-bunch charge
- Online bunch-by-bunch beam life time measurement
- High-efficiency bunch injection for top-up operation, which is the basis for providing high-quality SR light

SXFEL & SHINE

- Precise measurement of bunch charge and feedback
- High-precision beam loss monitor (~0.01%) for machine safety interlock

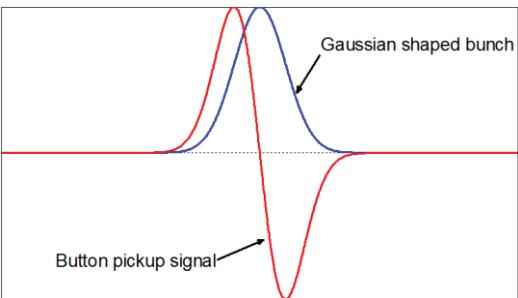
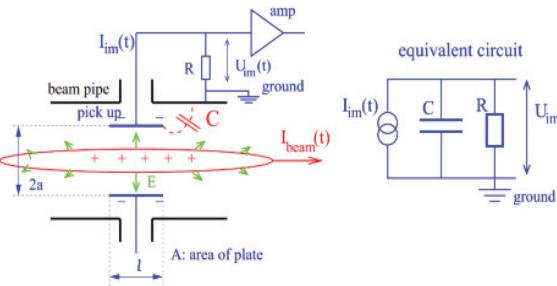


Theory & Simulation



Principle of measurement

- Button BPM

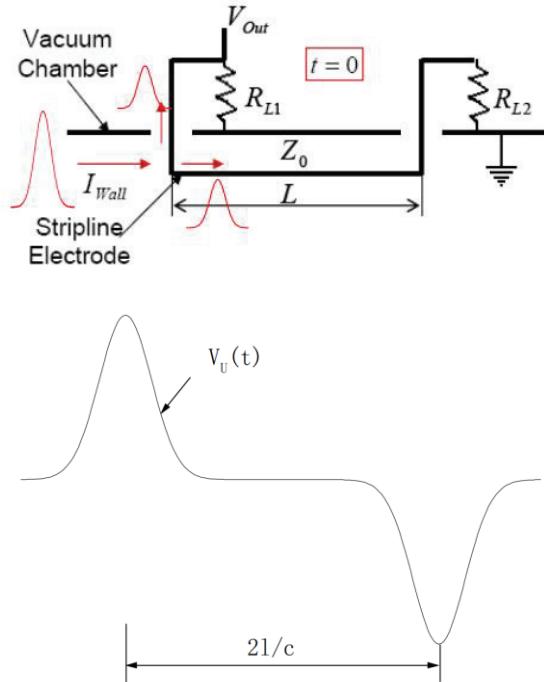


Charge

$$V_B(t) = \frac{Q}{2\pi^{3/2}} \cdot \frac{\phi l R}{\beta_b c} \cdot \frac{t}{\sigma_t^3} \cdot e^{-\frac{t^2}{2\sigma_t^2}}$$

Bunch length

- Stripline BPM

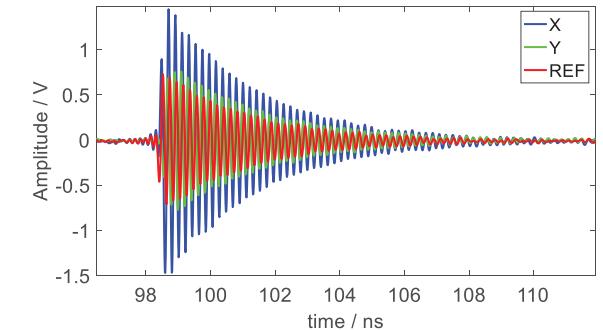
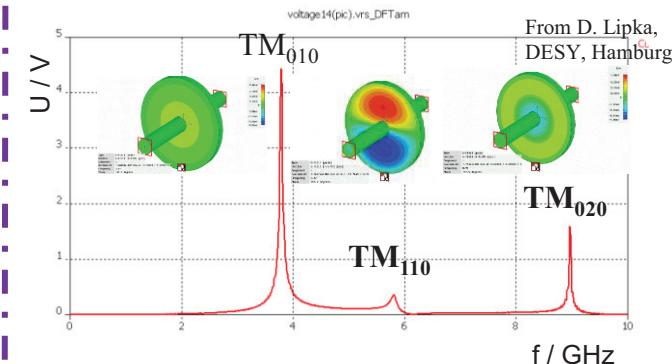


Charge

$$V(t) = \frac{\phi Z}{4\pi} \left[e^{-\frac{t^2}{2\sigma^2}} - e^{-\frac{(t-\frac{2l}{c})^2}{2\sigma^2}} \right] \cdot \frac{Q}{\sqrt{2\pi}\sigma}$$

Bunch length

- Cavity BPM



Charge

Cavity length

$$V_p^{010} = \frac{q\omega_{010}}{2} \cdot \sqrt{\frac{Z}{Q_{ext}^{010}}} \cdot \frac{2LT^2}{\epsilon\omega_{010}\pi a^2 J_1^2(\chi_{01})} \cdot J_0\left(\frac{\chi_{01}}{a}\rho\right) \cdot e^{-\frac{t}{\tau_{010}}} \cdot e^{-\frac{\omega_{010}^2 \sigma_z^2}{2c^2}} \cdot \sin(\omega_{010}t + \phi)$$

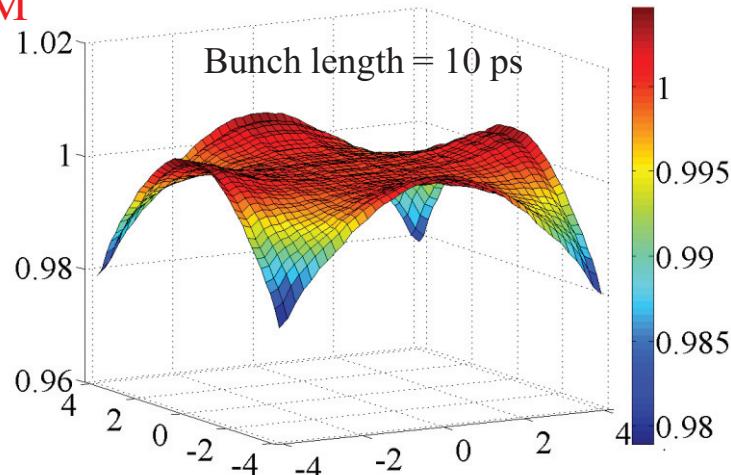
Bunch length



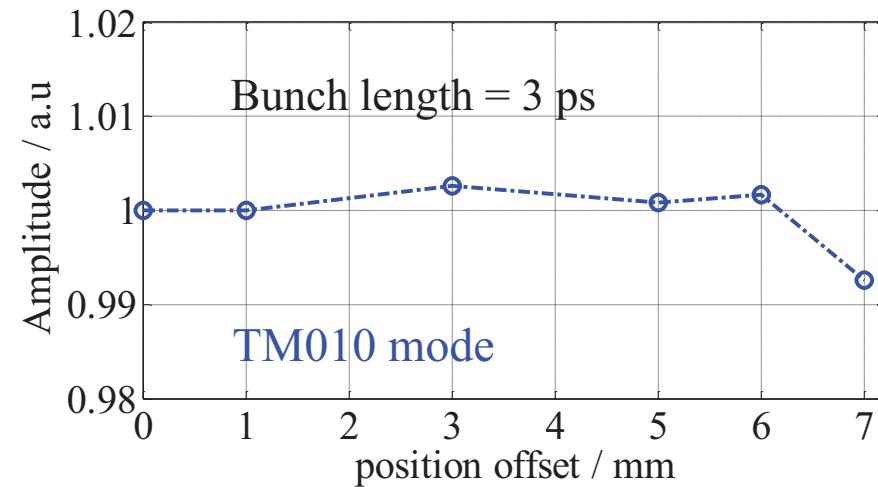
Simulation of Dependency

Transverse Position Dependency

SBPM



CBPM

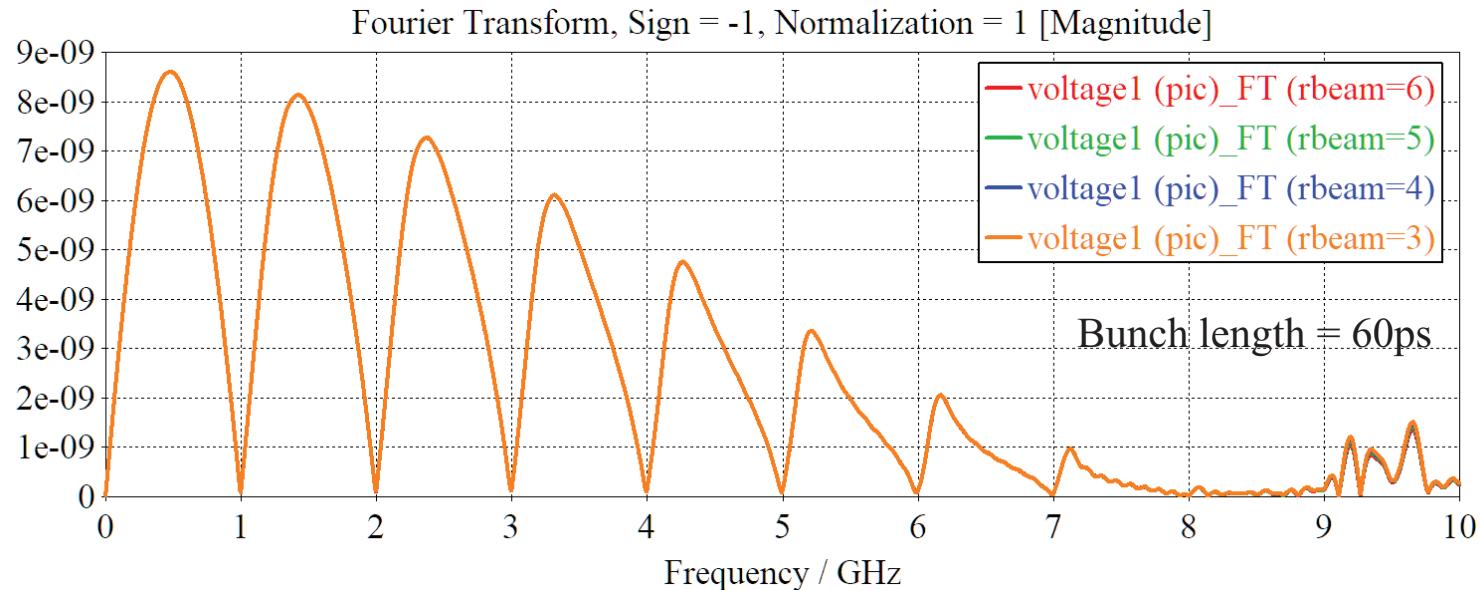


- Sum signal has a **hyperbolic parabolic relationship** with bunch position
- Based on the simulation results, the bunch position offsets needs **< (1mm,1mm)** if want to achieve **0.01%** bunch charge measurement resolution
- In the case of **position offset within 6mm**, TM010 mode signal has **no obvious position dependence**
(The error is limited by the accuracy of the meshing of the simulation tool)
- All parameters used for simulation comes from SSRF and SXFEL

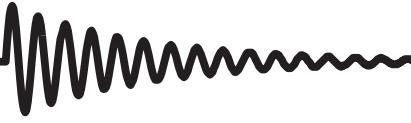


Simulation of Dependency

□ Transverse Distribution Dependency

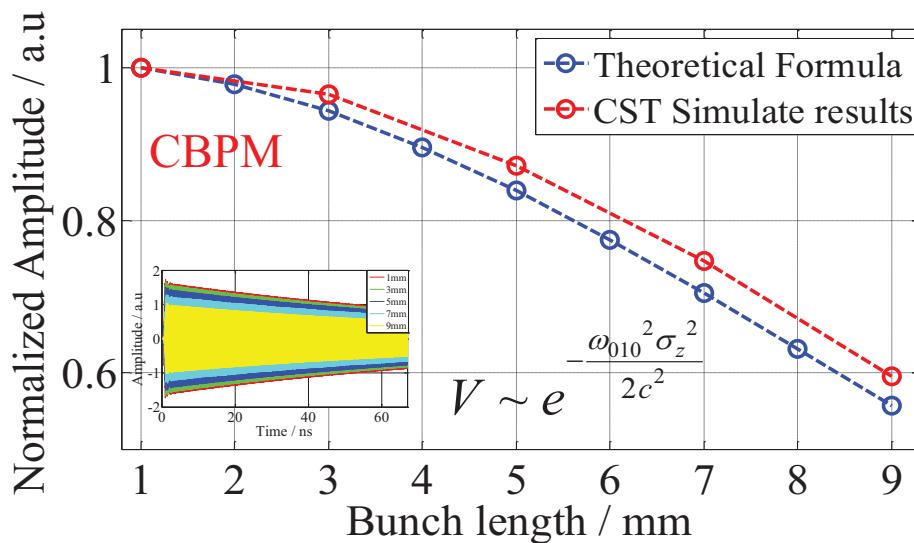
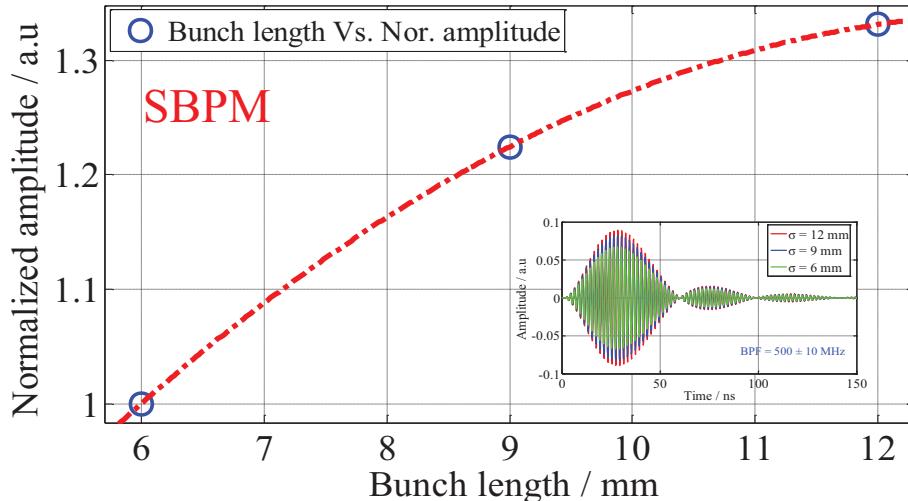


- For SBPM, when the **operating frequency < 10 GHz**, the transverse distribution dependence is **less than 0.01%**, so the influence on the measurement of the bunch charge **can be ignored**
- For Cavity BPM, no big difference in position dependence within 6mm; Theoretically, there will be no obvious dependence on transverse distribution



Simulation of Dependency

□ Bunche length Dependency



- Base on the results, the output signal changes about 4% when the bunch length changes 0.5ps around 2ps was estimated

- The simulation results are in good agreement with the theoretical formula
- Considering the working bunch length is 2ps, the bunch length jitter need < 7% if want to achieve 0.01% measurement resolution



Theoretical Limit

- Ideal DAQ and processing system, the probe information can be obtained completely --
- limited by thermal noise of the system
- Thermal noise : $V_n = \sqrt{4kTRB}$ 0.92uV/sqrt(MHz)@50Ω·300K

□ For Cavity BPM - TM010 mode:

$$V_p^{010} = \frac{q\omega_{010}}{2} \sqrt{\frac{Z}{Q_{ext}^{010}} \cdot \left(\frac{R}{Q}\right)}$$

Parameters of SXFEL :

$$\begin{aligned}f_{010} &= 4.693\text{GHz} \\BW_{3dB} &= 2\text{MHz} \\Q_{ext} &= 1.54 \cdot E4\end{aligned}$$



Sensitive: 5.4V/nC



- 100MHz bandwidth system, theoretical limit: ~ 1.7 fC

□ For Stripline BPM :

$$V(t) = \frac{\phi Z}{4\pi} \left[e^{-\frac{t^2}{2\sigma^2}} - e^{-\frac{(t-\frac{2l}{c})^2}{2\sigma^2}} \right] \cdot \frac{Q}{\sqrt{2\pi}\sigma}$$

Parameters of SXFEL :

$$\sigma = 2\text{ps}$$

$$l = 150\text{mm}$$

$$\varphi = 30^\circ$$



Sensitive: ~12V / 0.1nC



- Ideal ADC, 100GHz BW, enough input range, theoretical limit: ~ 2.4 fC
- For 500 ± 10MHz BW, theoretical limit : ~ 4 fC



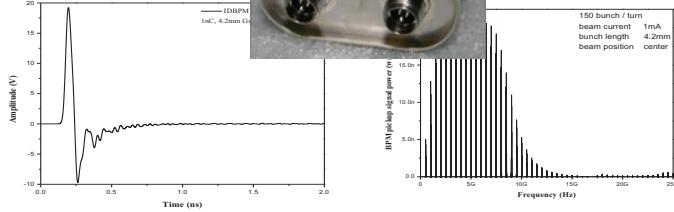
Signal conditioning & Data processing



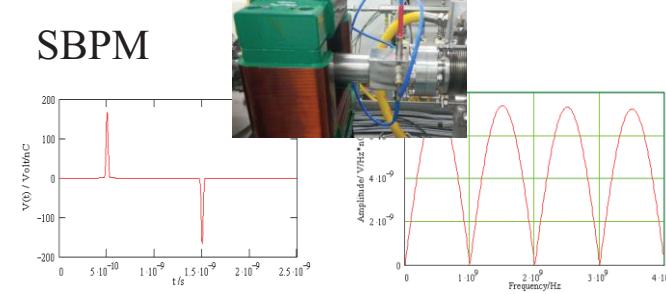
Signal conditioning & Data processing

□ Signal conditioning methods @ SBPM & Button BPM

Button BPM



SBPM



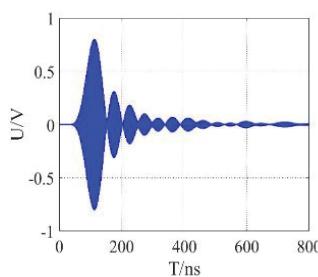
Signal conditioning / Sampling method

Narrow - band

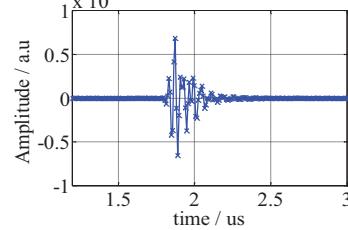
Broad - band

Signal filter broadening

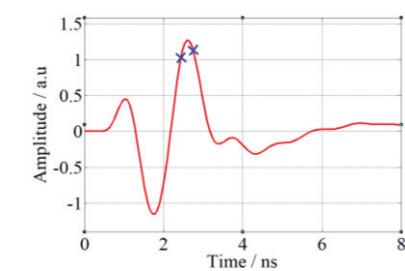
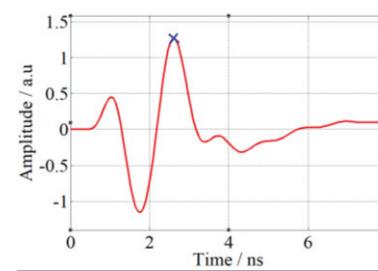
Peak Sampling



+ ADC



Int / Ext Clock / Trigger

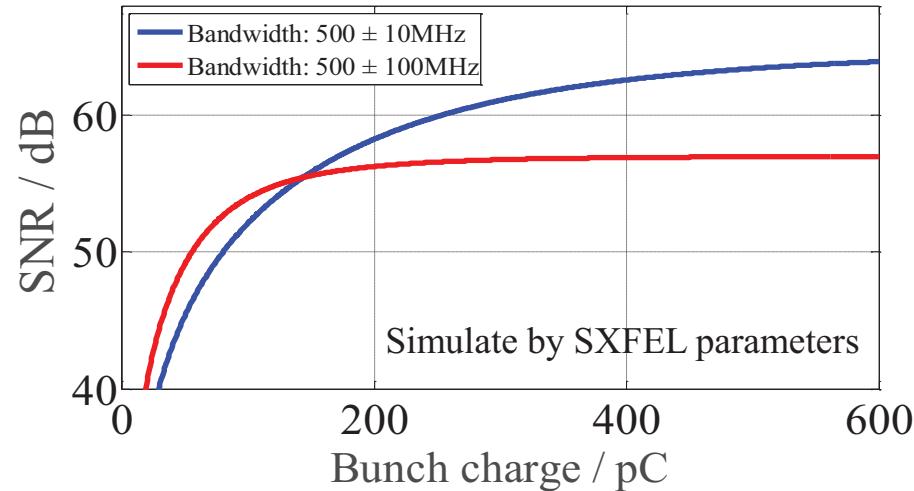
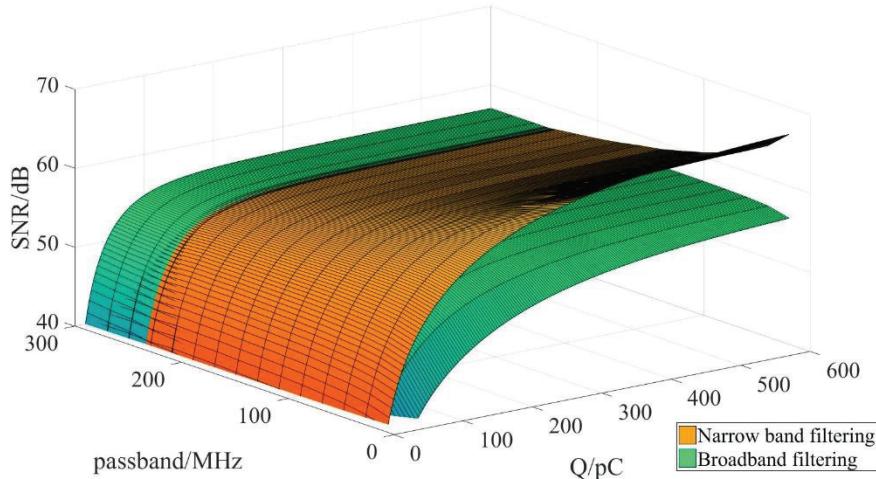


Ext Clock / Trigger

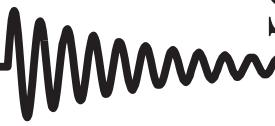


Signal conditioning & Data processing

□ Choice of Narrow-band filtering & Wide-band sampling



- With a bigger bunch charge, the narrow-band filtering method can obtain larger processing gain and better SNR
- With a smaller bunch charge, the wide-band sampling method can output more energy and can improve the single-point SNR

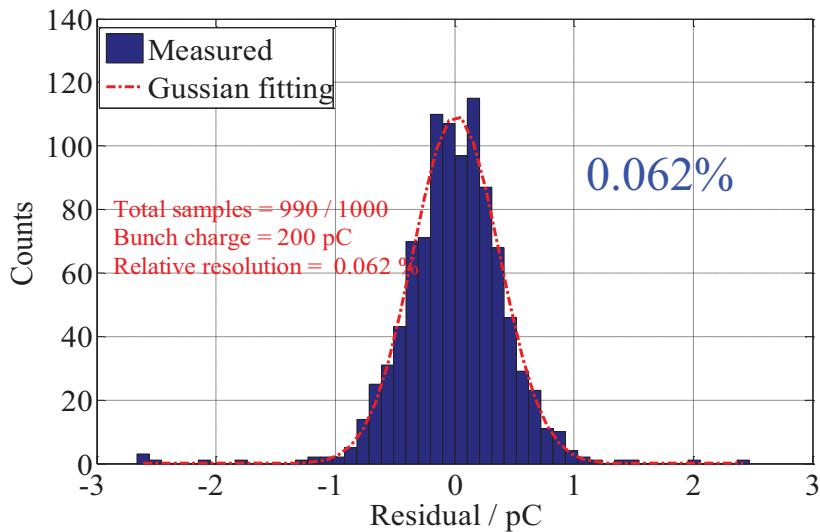


Signal conditioning & Data processing

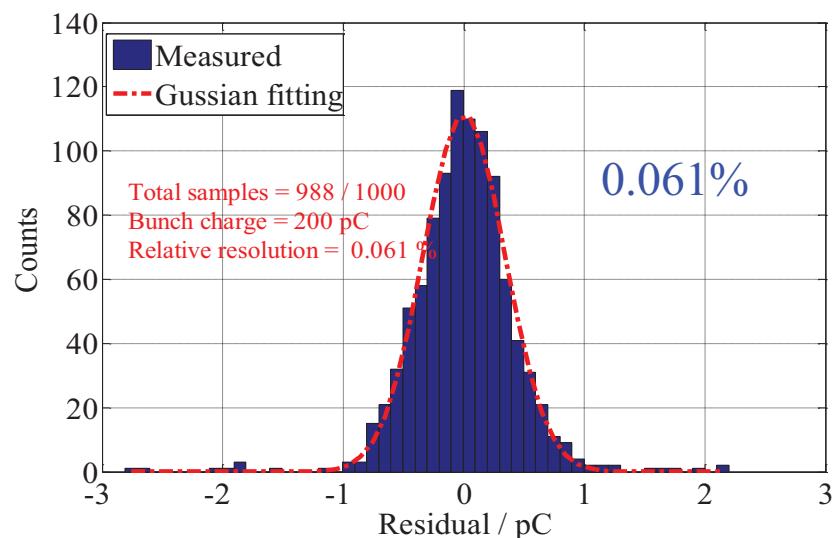
□ Internal / External Clock & Trigger @ SXFEL

Narrowband Filtering

Internal Clock & Trig



External Clock & Trig



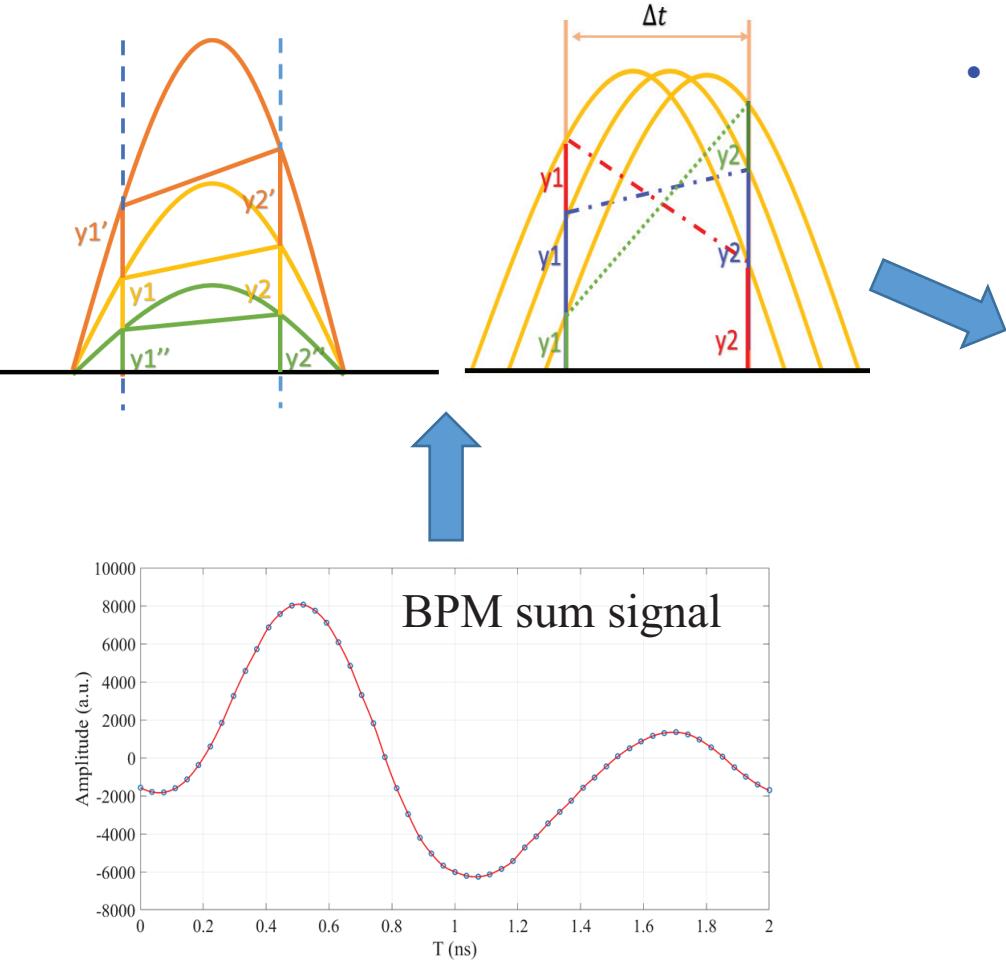
- when the ADC sampling rate is much larger than the system bandwidth (at least 4 times), there has no big difference in the improvement of resolution by external clock and trigger



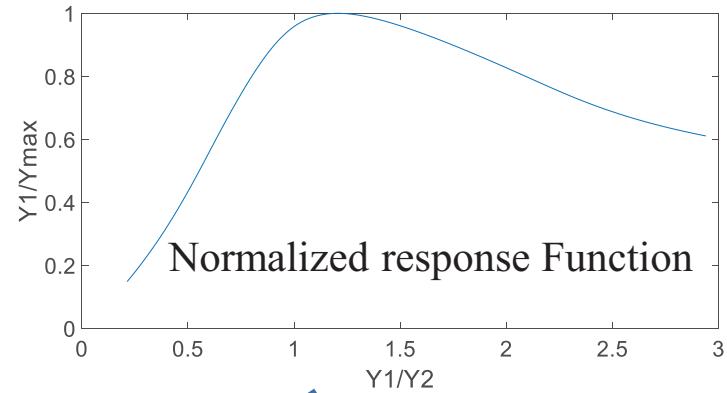
Signal conditioning & Data processing

IBIC'19 MOC001

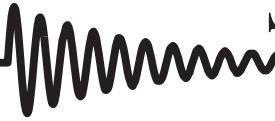
- SBPM / Button BPM --- “ Two-phase sampling based peak seeking method ”



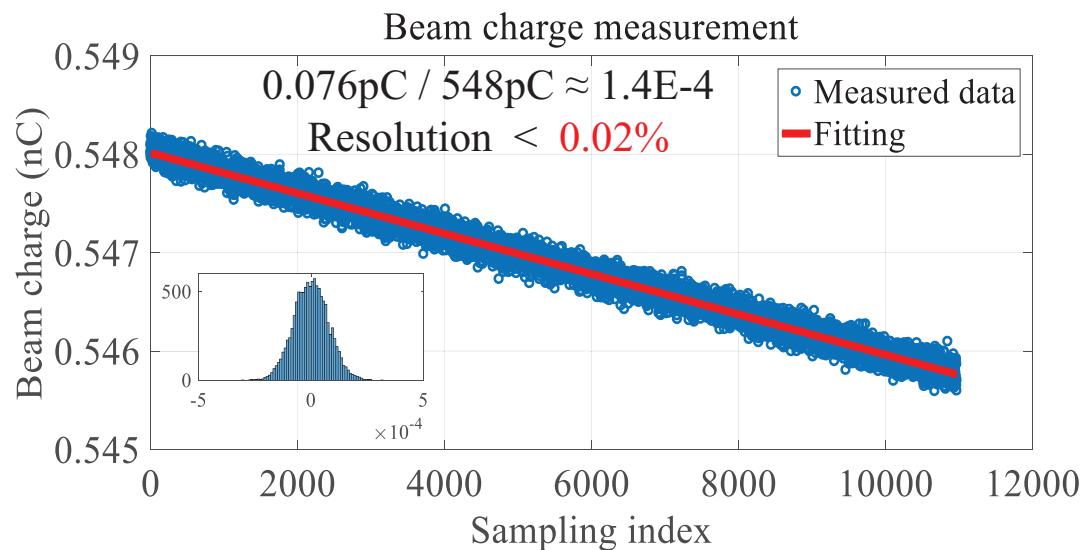
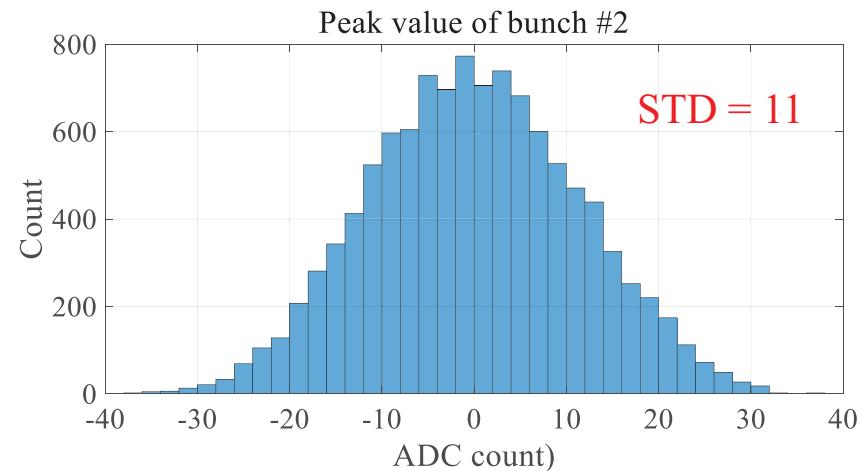
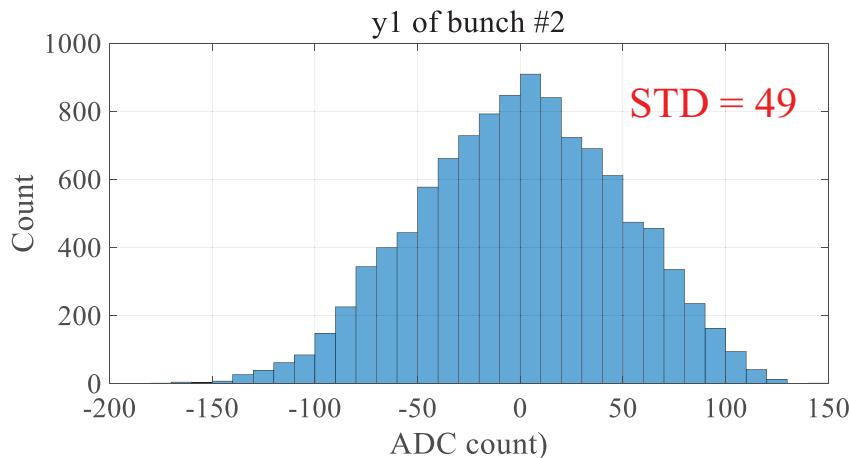
- Target: Minimize the impact of **sampling phase jitter**



$$\frac{y_1}{y_{peak}} = f\left(\frac{y_1}{y_2}\right)$$



Signal conditioning & Data processing

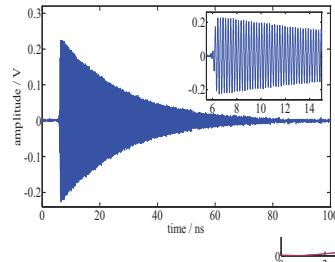


- “Two-phase sampling based peak seeking method” basically **minimized the influence of sampling phase jitter**
- Resolution of beam charge measurement better than **0.02%**
(1W+ sets of data average)

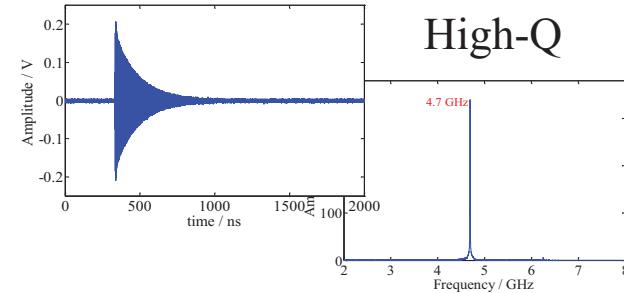


Signal conditioning & Data processing

□ Signal conditioning methods @ Cavity BPM



Low-Q



High-Q

Signal conditioning / sampling method

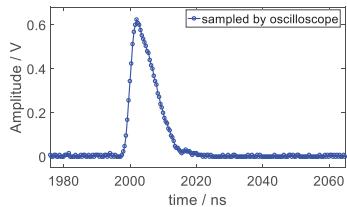
Down Conversion

RF Sampling

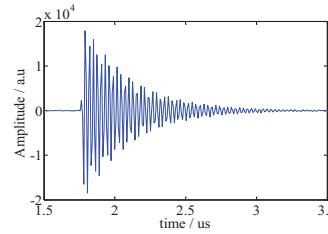
Low-Q

High-Q

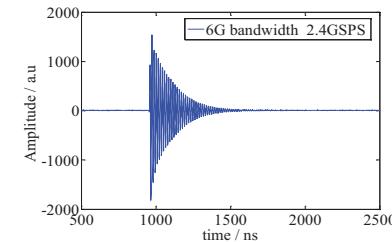
Analog IQ demodulation



Down Conversion to low IF



ADC with High bandwidth,
sampling rate



- High Q Cavity can get more processing gain (longer decay time), the algorithm is also more diversified
- Optimize the **data processing window** can improve the system resolution effectively

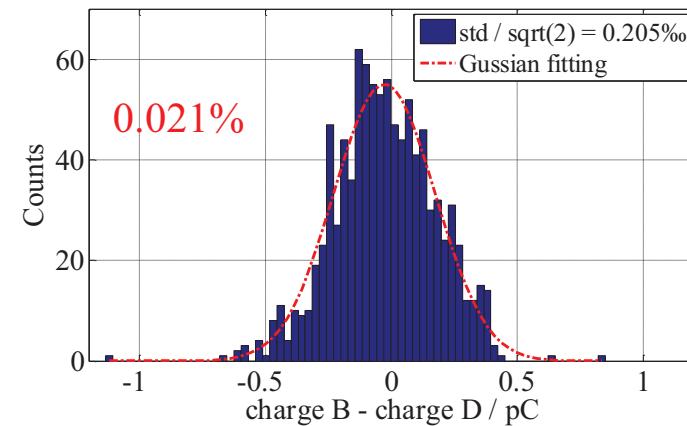
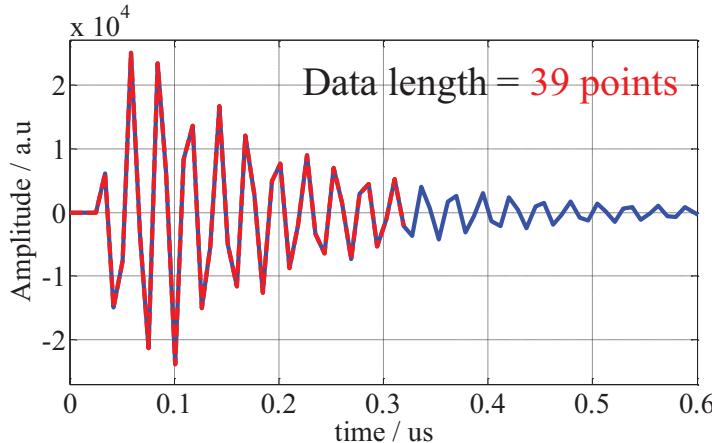
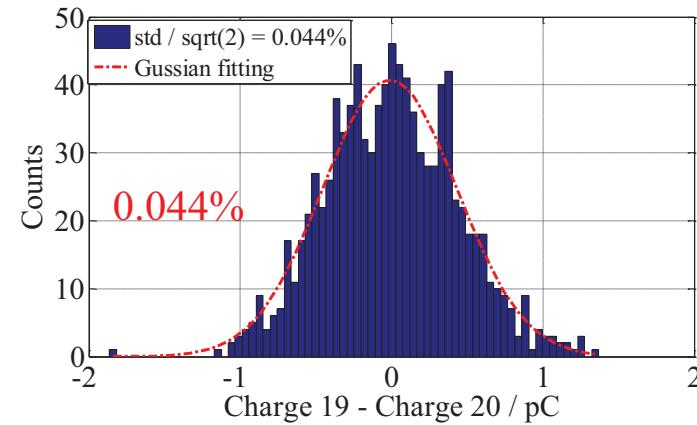
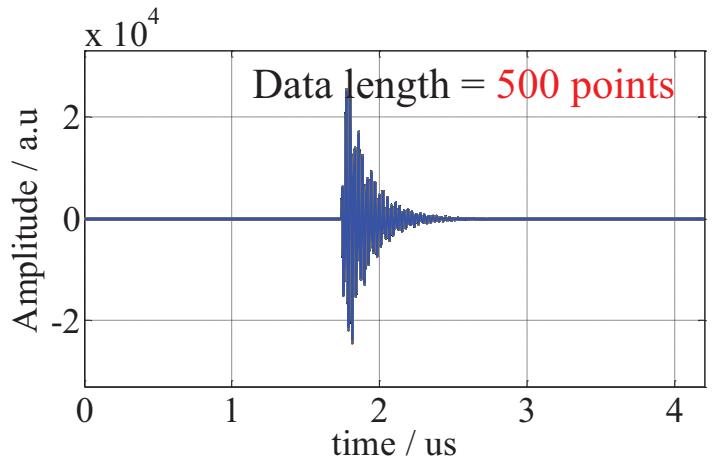


Signal conditioning & Data processing

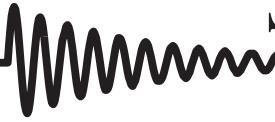
- Performance after select data processing window @ SXFEL

Frequency: 4.7GHz

Loaded Q: 2350

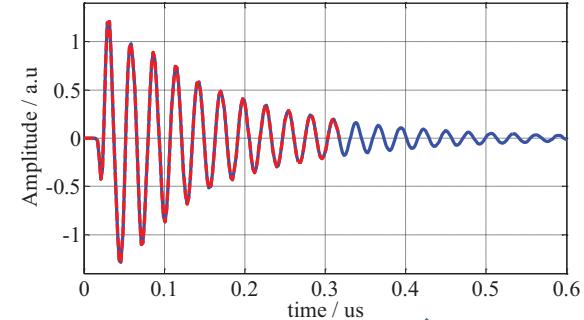
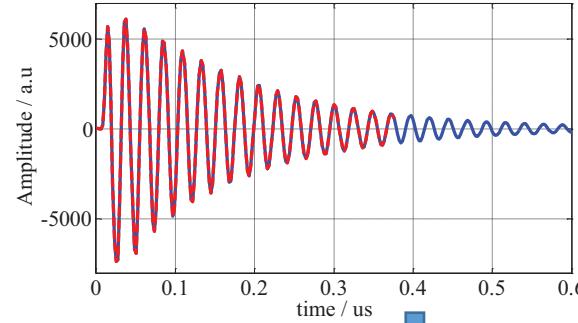
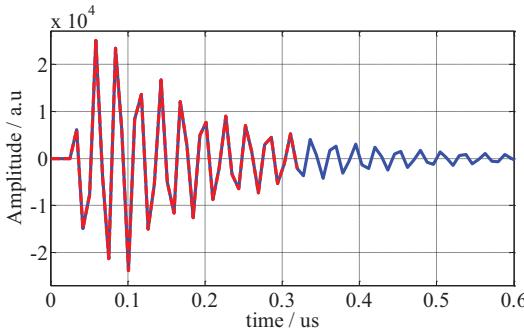


- By selecting an appropriate data processing window, the relative resolution can be improved from 0.044% to 0.021%



Signal conditioning & Data processing

□ Comparison of different DAQ system @ SXFEL



	Digital BPM (Homemade by SSRF)	Libera Digit 500	NI - 5772
Parameters	119 MSPS, 16 bit	476 MSPS, 14 bit	476 MSPS, 12 bit
Data Length	327 ns	378 ns	319 ns
Relative Resolution	0.044% → 0.021 %	0.065% → 0.036 %	0.083% → 0.047 %

- Different parameters DAQ system, By selecting the appropriate data processing window, the performance is nearly doubled



Beam Experiment

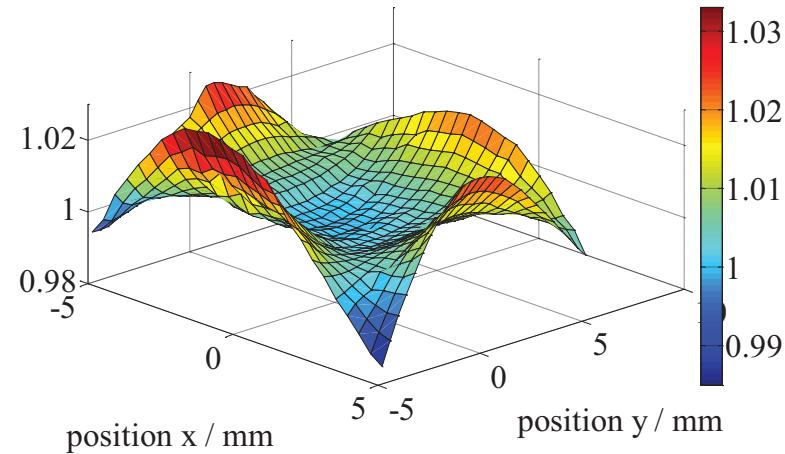
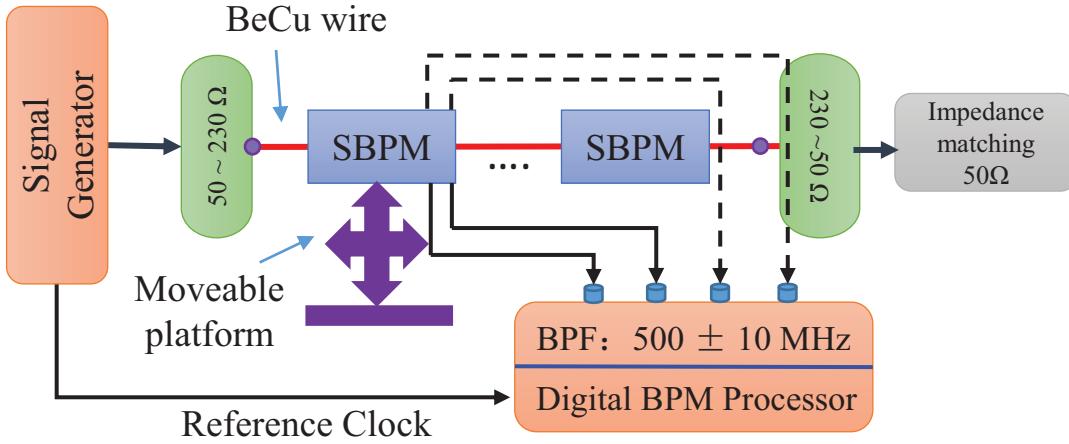
□ SSRF

- Position dependence evaluation
- Performance evaluation (BYB charge monitor)

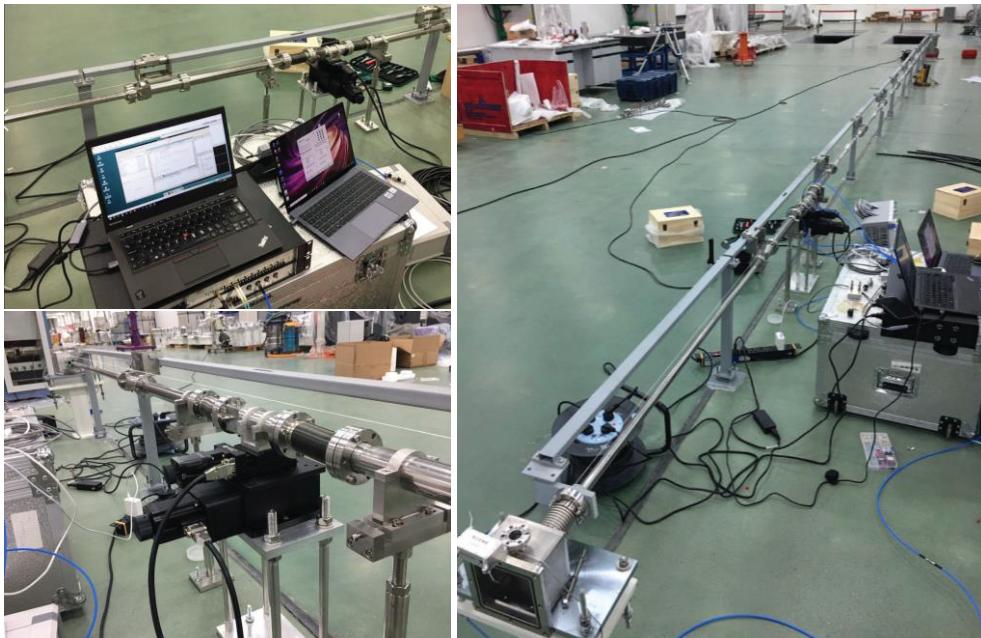
□ SXFEL

- Bunch length dependence evaluation @ SBPM
- Position dependence evaluation @ CBPM

Position dependence -- SBPM

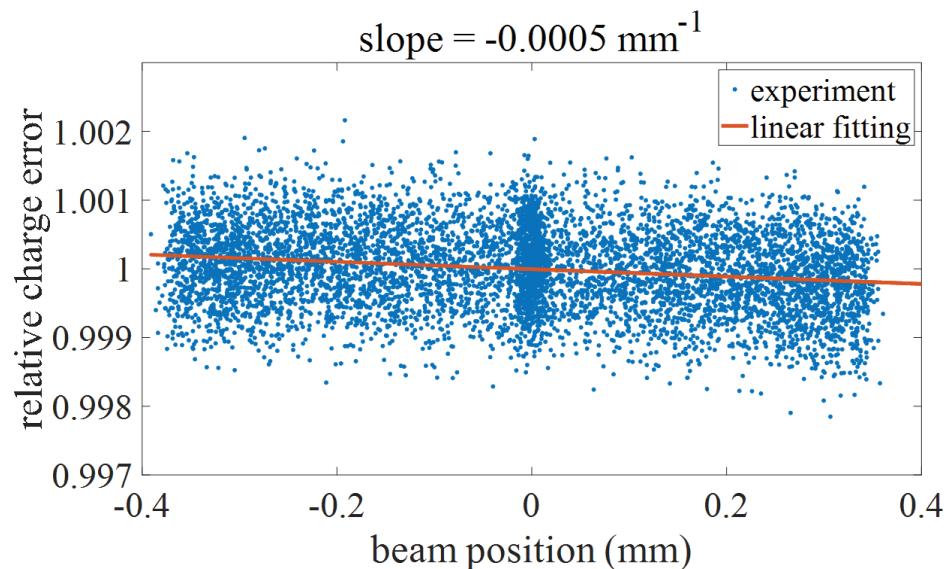
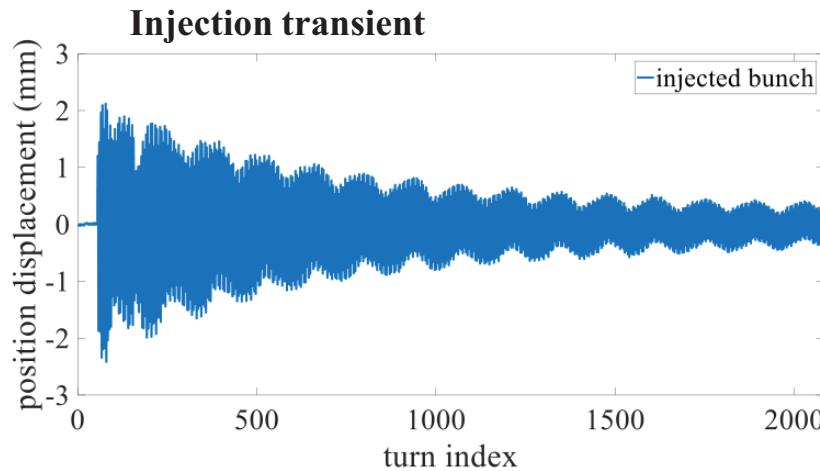


- A wire passes through BPM to simulate beam offset to verify the dependence of sum signal and position
- Qualitatively verified that the relationship is hyperboloid





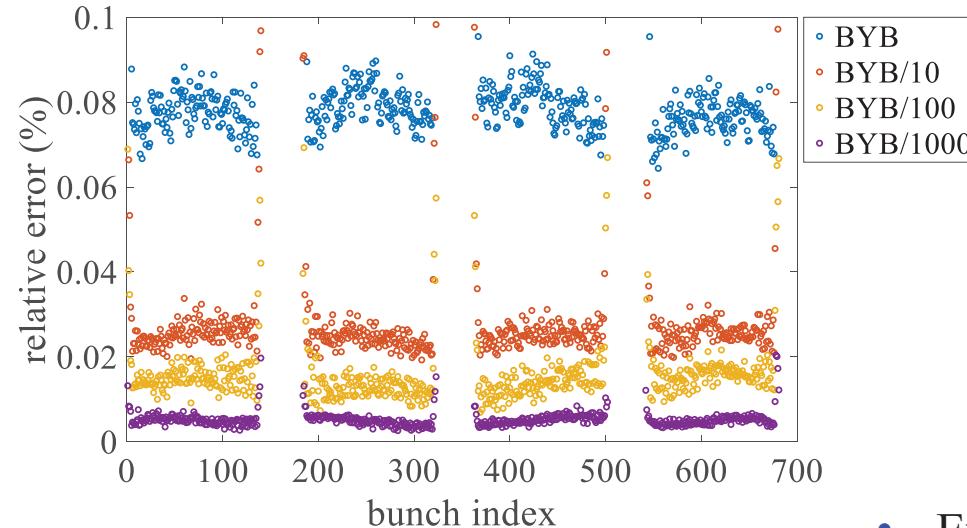
Position dependence -- Button BPM



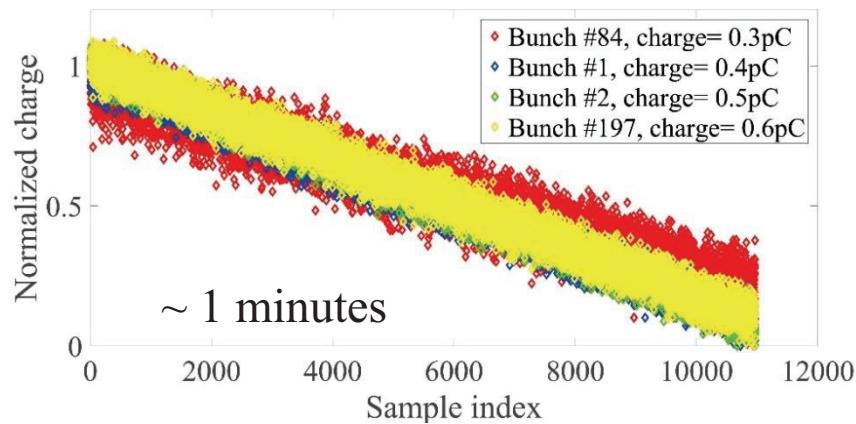
- The data of the beam position during the injection transient was used to evaluate the position dependence, the results shows that the **slope is about $0.0005 / \text{mm}$**
- Closed-orbit measurement, position jitter controlled within micro-meter level, the contribution of position dependence is about **$1\text{E}-6$**
- Turn-by-Turn measurement, the contribution of position dependence is about **$1\text{E}-5$**
($10 \sigma \sim 20 \text{ um}$)



Performance (BYB charge monitor)



Data rate	Relative Error (σ)	10σ	600pC
TBT	8E-4	8E-3	5pC
69kHz	3E-4	3E-3	2pC
7kHz	1.5E-4	1.5E-3	1pC
700Hz	5E-5	5E-4	0.3pC



- Evaluate the BPM pickup to measure the charge of BYB, the resolution can reach **8E-4** (694KHz data rate)
- For the charge measurement of the **storage ring**, **the position dependence is negligible**
- Assume the beam with lifetime $\sim 10\text{h}$, bunch decay $\sim 3\text{E-}5/\text{s}$. The system can achieve BYB lifetime measurement within tens of seconds



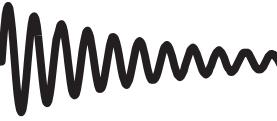
Beam Experiment

□ SSRF

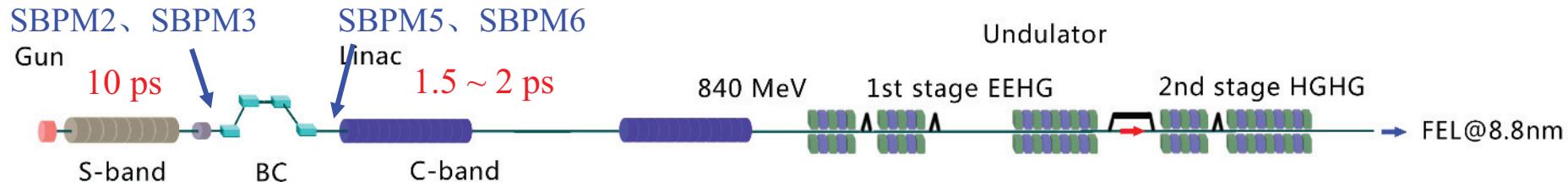
- Position dependence evaluation
- Performance evaluation (BYB charge monitor)

□ SXFEL

- Bunch length dependence evaluation @ SBPM
- Position dependence evaluation @ CBPM



Bunch length dependence -- SBPM

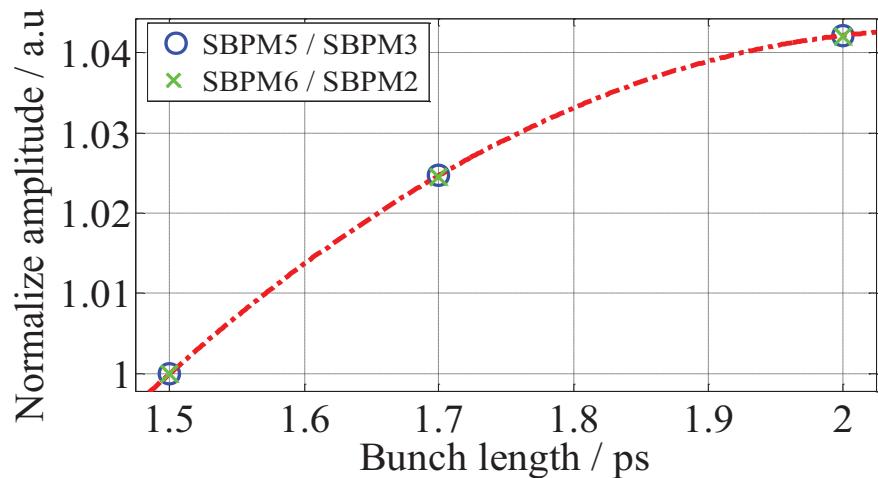


Injector beam parameters

Bunch charge (nC)	0.5
Beam energy (MeV)	129.4
Pulse length (ps, FWHM)	10
Norm. emittance (mm.mrad, rms)	0.95
Rep-rate (Hz)	1-10

Main linac beam parameters

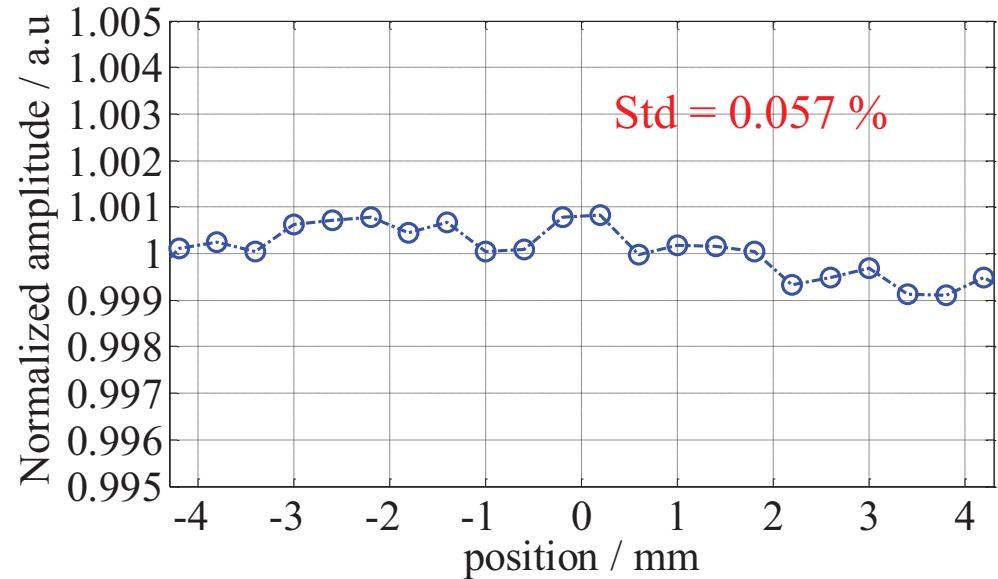
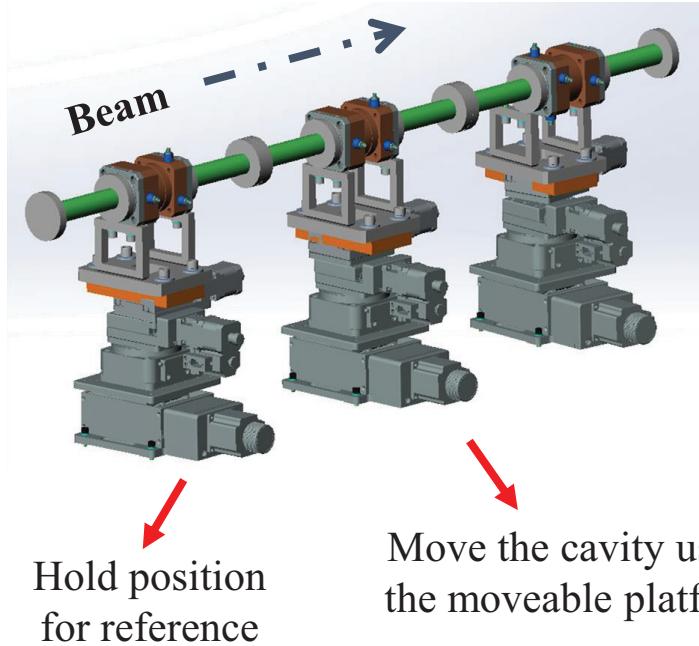
Bunch charge (nC)	0.5
Beam energy (GeV)	0.8
Bunch length (ps, FWHM)	1.5
Norm. emittance (mm.mrad)	< 2.0
Peak current (A)	≥ 500



- Bunch length can be adjusted from 1.5ps to 2ps in BC section
- Bunch length changed from 1.5 to 2ps, **the sum signal changed 4.2%**, consistent with the simulation results
- Bunch length jitter need to be **controlled with 0.1%** if want to achieve 0.01% resolution



Position dependence -- CBPM



- The range of the movable platform is limited to $\pm 4.2\text{mm}$
- Within $\pm 4.2\text{mm}$, the position dependence of the TM010 cavity can be ignored, which is consistent with the simulation results



Discussion & Summary

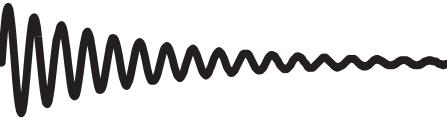


Discussion 1 -- Update the current system

BPM for high precision beam loss monitor -- 0.01% resolution for key area (SHINE)

	Cavity BPM pickup	RF Front-end	DAQ system
Parameters	Frequency: 4.7 GHz Loaded Q: 2350	One channel to IF ~ 30MHz	4 channels, 119MSPS, 16 bit Bandwidth(ADC): 650 MHz
Performance	Thermal noise: -110dB (2MHz BW)	NF ~ 15	ADC noise level: 2.35 std (ENOB = 12.5)

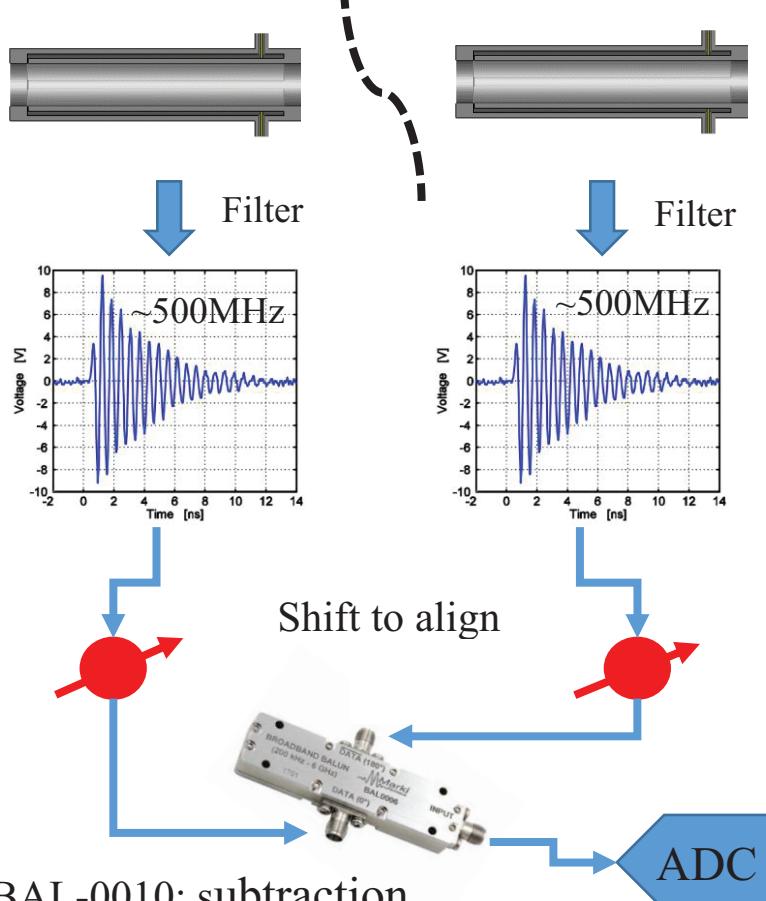
- Current CBPM system in SXFEL can achieve the resolution of 2.1%
- Performance limited by the RF front-end, if $NF < 9$, the resolution of 0.01% can be achieved for current system
- New RF front-end for SHINE optimized to 8.5, can achieve $< 0.01\%$ in theory (waiting for beam experiment)



Discussion 2 – New Propose

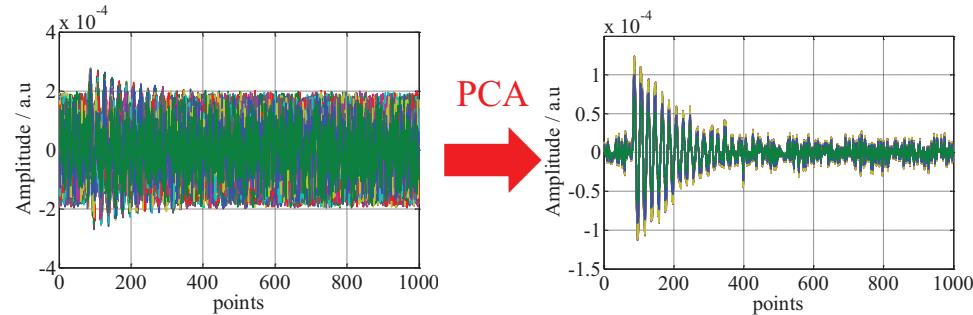
BPM for high precision beam loss monitor -- 0.01% resolution for key area (SHINE)

Resonant SBPM

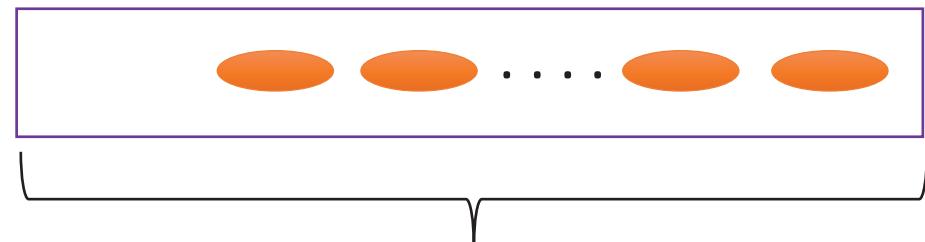


Weak signal amplified and quantified

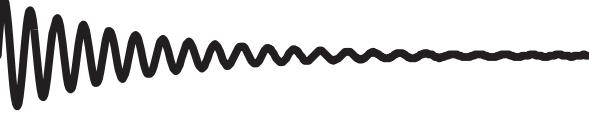
Simulate 0.01% beam loss, PCA for noise reduction



Thinking: PCA implemented in FPGA?

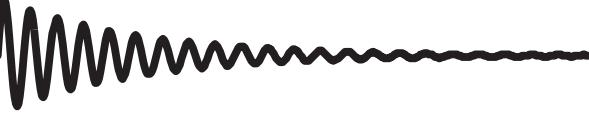


Set a buff to keep ~100 bunches of BPM data for PCA processing



Summary 1

- BPM pickup can be used for precise bunch charge measurement
- The beam experiment results are basically in agreement with the theoretical simulation results; And Cavity pickup has less dependence on transverse position, transverse distribution and bunch length, more suitable for precise bunch charge measurement
- For Cavity pickup, the system resolution can be improved by optimizing the data processing window; In the SXFEL, the relative bunch charge resolution of the system can reach 0.021%
- The relative resolution of the SXFEL CBPM system is limited by the RF front-end, and when the $\text{NF} < 9$ is optimized, the measurement resolution requirement of 0.01% can be achieved
- Propose a new method based on differential resonant SBPM, which also is expected to meet the requirement of 0.01%



Summary 2

- In the storage ring of SSRF, the BPM pickup is used to measure the charge of BYB, the resolution can reach 8E-4 (694KHz data rate)
- Analyzed the position dependence of BPM in SSRF, combined with position stability of closed orbit and TBT, the error introduced by the position dependence can be ignored
- Therefore, it is very promising for BPM to achieve high-speed and precise BYB charge measurement in storage ring. It also can be used as a tool for beam loss and online bunch-by-bunch beam life time measurement



Thanks for your attention

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